AMENDMENTS TO THE CLAIMS

Please amend the following claims which are pending in the present application:

(Currently Amended) A system for photoresist recovery comprising: 1.

a nozzle to dispense a photoresist;

a bowl having an interior region and an interior surface;

a wafer platform disposed within the interior region of the bowl;

a wafer spindle coupled to the wafer platform, the wafer spindle to spin the wafer

platform to propel propel an excess amount of a photoresist deposited upon a wafer placed

upon the wafer platform to the interior surface of the bowl; and

a photoresist recovery container; and

a perimeter drain formed within the bowl such that the excess amount of photoresist

propelled from the wafer proceeds through the perimeter drain to the photoresist recovery

container;

wherein the perimeter drain comprises a concaved conduit for reducing the surface

area contacting the photoresist being recovered; and

a weeping seal to permit a wash solvent to wash the excess amount of photoresist

propelled from the wafer through the perimeter drain to the photoresisit recovery container.

2. (Original) The system of claim 1 wherein the photoresist recovery container is

coupled to the bowl via a recovery drainpipe.

3. (Original) The system of claim 2 further comprising:

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a recovery drainpipe block capable of being positioned in front of the recovery drainpipe to prevent contaminates from entering the recovery drainpipe.

- 4. (Previously Presented) The system of claim 1 wherein the perimeter drain is formed level with a wafer rotation position within the interior surface of the bowl.
- 5. (Previously Presented) The system of claim 1 further comprising a solvent vapor supply means coupled to the recovery drainpipe to provide a solvent-rich environment within the recovery drainpipe.
- 6. (Cancelled)
- 7. (Cancelled)
- 8. (Currently Amended) The system of claim 4 30, further comprising:

 one or more additional perimeter drains formed within the bowl to recover one or

 more additional types of photoresists in corresponding photoresist recovery containers.
- 9-27. (Cancelled)
- 28. (New) The system of claim 1, wherein the wash solvent is the same as or compatible with the solvent used in the photoresist being recovered.
- 29. (New) The system of claim 1, wherein the perimeter drain is angled so as to facilitate the movement of photoresist to the recovery drain.

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30. (New) The system of claim 1, further comprising a waste drain formed within the

bowl.

31. (New) The system of claim 1, further comprising a filtering apparatus to remove

particles from the recovered photoresist.

32. (New) The system of claim 1, further comprising a treating apparatus to treat the

recovered resist to permit its reuse.

33. (New) The system of claim 32, wherein the treating apparatus further comprises a

viscosity monitoring apparatus used to control the addition or evaporation of solvent, to or

from the recovered photoresist.

34. (New) The system of claim 1, wherein the concave conduit comprises an

approximately semicircular toroid shape.

35. (New) A system for photoresist recovery comprising:

a nozzle to dispense a photoresist;

a bowl having an interior region and an interior surface;

a wafer platform disposed within the interior region of the bowl;

a wafer spindle coupled to the wafer platform, the wafer spindle to spin the wafer

platform to propel an excess amount of a photoresist deposited upon a wafer placed upon

the wafer platform to the interior surface of the bowl;

a photoresist recovery container;

a perimeter drain formed within the bowl such that the excess amount of photoresist

propelled from the wafer proceeds through the perimeter drain to the photoresist recovery

container;

a waste drain formed within the bowl; and

one or more additional perimeter drains formed within the bowl to recover one or

more additional types of photoresists in corresponding photoresist recovery containers.

36. (New) The system of claim 35, wherein the spindle is adjustable to alternate

spindle heights to accommodate one or more of the additional perimeter drains.

37. (New) The system of claim 35, wherein the position of the bowl is adjustable

relative to the wafer platform.

38. (New) The system of claim 35, further comprising a weeping seal to permit a wash

solvent to wash the excess amount of photoresist propelled from the wafer through one of

the perimeter drains to the corresponding photoresisit recovery container.

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